

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/660,620	MURAKAMI ET AL.	
Examiner	Art Unit	
Sonhia S. Chen	2852	

	SEARCHED					
Class	Subclass	Date	Examiner			
399	358	6/28/2005	sc			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
as a	bove	6/28/2005	sc		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
None		6/28/2005	sc	